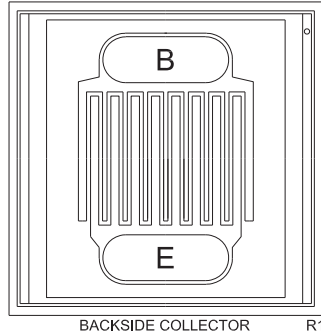


CP337V-2N4014

NPN - General Purpose Transistor Die

The CP337V-2N4014 is a silicon NPN transistor designed for general purpose switching applications.



MECHANICAL SPECIFICATIONS:

Die Size	29 x 29 MILS
Die Thickness	7.1 MILS
Base Bonding Pad Size	11.8 x 4.5 MILS
Emitter Bonding Pad Size	11.8 x 4.5 MILS
Top Side Metalization	Al – 30,000Å
Back Side Metalization	Au-As – 13,000Å
Scribe Alley Width	2.0 MILS
Wafer Diameter	4 INCHES
Gross Die Per Wafer	13,192

MAXIMUM RATINGS: (T_A=25°C)

	SYMBOL		UNITS
Collector-Base Voltage	V _{CB0}	80	V
Collector-Emitter Voltage	V _{CE0}	40	V
Emitter-Base Voltage	V _{EBO}	6.0	V
Continuous Collector Current	I _C	1.0	A
Peak Collector Current	I _{CM}	2.0	A
Operating and Storage Junction Temperature	T _J , T _{stg}	-65 to +150	°C

ELECTRICAL CHARACTERISTICS: (T_A=25°C unless otherwise noted)

SYMBOL	TEST CONDITIONS	MIN	MAX	UNITS
I _{CBO}	V _{CB} =60V		1.7	μA
I _{CES}	V _{CE} =80V		10	μA
BV _{CBO}	I _C =10μA	80		V
BV _{CES}	I _C =10μA	80		V
BV _{CEO}	I _C =10mA	40		V
BV _{EBO}	I _E =10μA	6.0		V
V _{CE(SAT)}	I _C =10mA, I _B =1.0mA		0.25	V
V _{CE(SAT)}	I _C =100mA, I _B =10mA		0.26	V
V _{CE(SAT)}	I _C =300mA, I _B =30mA		0.40	V
V _{CE(SAT)}	I _C =500mA, I _B =50mA		0.52	V
V _{CE(SAT)}	I _C =800mA, I _B =80mA		0.80	V
V _{CE(SAT)}	I _C =1.0A, I _B =100mA		0.95	V
V _{BE(SAT)}	I _C =10mA, I _B =1.0mA		0.76	V
V _{BE(SAT)}	I _C =100mA, I _B =10mA		0.86	V
V _{BE(SAT)}	I _C =300mA, I _B =30mA		1.1	V
V _{BE(SAT)}	I _C =500mA, I _B =50mA	0.80	1.1	V
V _{BE(SAT)}	I _C =800mA, I _B =80mA		1.5	V
V _{BE(SAT)}	I _C =1.0A, I _B =100mA		1.7	V

R0 (6-June 2016)

CP337V-2N4014

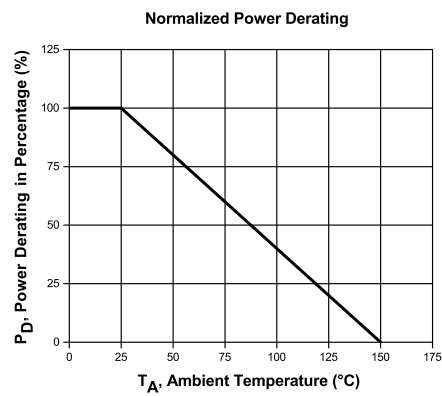
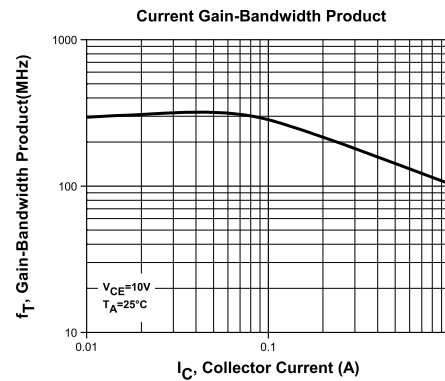
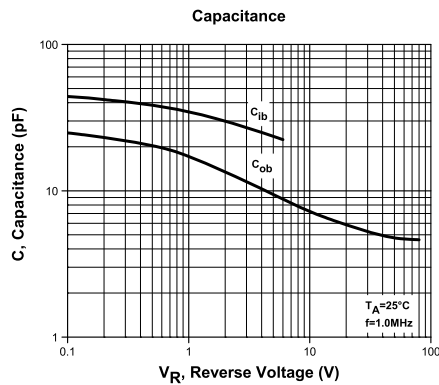
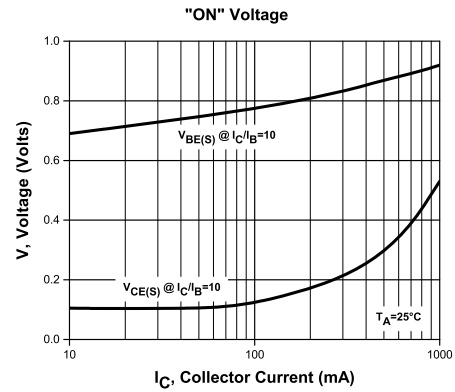
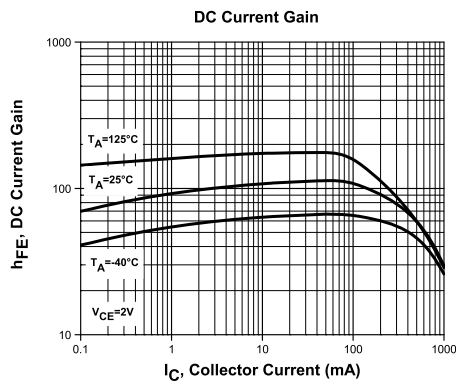
Typical Electrical Characteristics

ELECTRICAL CHARACTERISTICS - Continued: ($T_A=25^{\circ}\text{C}$ unless otherwise noted)

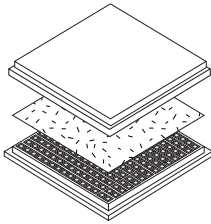
SYMBOL	TEST CONDITIONS	MIN	MAX	UNITS
h_{FE}	$V_{CE}=1.0\text{V}, I_C=10\text{mA}$	30		
h_{FE}	$V_{CE}=1.0\text{V}, I_C=100\text{mA}$	60	150	
h_{FE}	$V_{CE}=1.0\text{V}, I_C=300\text{mA}$	40		
h_{FE}	$V_{CE}=1.0\text{V}, I_C=500\text{mA}$	35		
h_{FE}	$V_{CE}=2.0\text{V}, I_C=800\text{mA}$	20		
h_{FE}	$V_{CE}=5.0\text{V}, I_C=1.0\text{A}$	25		
f_T	$V_{CE}=10\text{V}, I_C=50\text{mA}, f=100\text{MHz}$	300		MHz
C_{ob}	$V_{CB}=10\text{V}, I_E=0, f=1.0\text{MHz}$		10	pF
C_{ib}	$V_{EB}=0.5\text{V}, I_C=0, f=1.0\text{MHz}$		55	pF
t_d	$V_{CC}=30\text{V}, I_C=500\text{mA}, I_{B1}=50\text{mA}$		10	ns
t_r	$V_{CC}=30\text{V}, I_C=500\text{mA}, I_{B1}=50\text{mA}$		30	ns
t_{on}	$V_{CC}=30\text{V}, I_C=500\text{mA}, I_{B1}=50\text{mA}$		35	ns
t_s	$V_{CC}=30\text{V}, I_C=500\text{mA}, I_{B1}=I_{B2}=50\text{mA}$		50	ns
t_f	$V_{CC}=30\text{V}, I_C=500\text{mA}, I_{B1}=I_{B2}=50\text{mA}$		25	ns
t_{off}	$V_{CC}=30\text{V}, I_C=500\text{mA}, I_{B1}=I_{B2}=50\text{mA}$		60	ns

CP337V-2N4014

Typical Electrical Characteristics



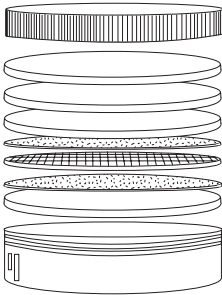
BARE DIE PACKING OPTIONS



BARE DIE IN TRAY (WAFFLE) PACK

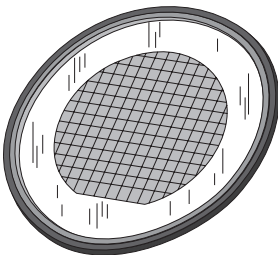
CT: Singulated die in tray (waffle) pack.
(example: CP211-PART NUMBER-CT)

CM: Singulated die in tray (waffle) pack 100% visually inspected as per MIL-STD-750, (method 2072 transistors, method 2073 diodes).
(example: CP211-PART NUMBER-CM)



UNSAWN WAFER

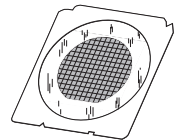
WN: Full wafer, unsawn, 100% tested with reject die inked.
(example: CP211-PART NUMBER-WN)



SAWN WAFER ON PLASTIC RING

WR: Full wafer, sawn and mounted on plastic ring, 100% tested with reject die inked.
(example: CP211-PART NUMBER-WR)

Please note: Sawn Wafer on Metal Frame (WS) is possible as a special order. Please contact your Central Sales Representative at 631-435-1110.



Visit the Central website for a complete listing of specifications:
www.centrasemi.com/bdspecs

OUTSTANDING SUPPORT AND SUPERIOR SERVICES



PRODUCT SUPPORT

Central's operations team provides the highest level of support to insure product is delivered on-time.

- Supply management (Customer portals)
- Inventory bonding
- Consolidated shipping options
- Custom bar coding for shipments
- Custom product packing

DESIGNER SUPPORT/SERVICES

Central's applications engineering team is ready to discuss your design challenges. Just ask.

- Free quick ship samples (2nd day air)
- Online technical data and parametric search
- SPICE models
- Custom electrical curves
- Environmental regulation compliance
- Customer specific screening
- Up-screening capabilities
- Special wafer diffusions
- PbSn plating options
- Package details
- Application notes
- Application and design sample kits
- Custom product and package development

REQUESTING PRODUCT PLATING

1. If requesting Tin/Lead plated devices, add the suffix "TIN/LEAD" to the part number when ordering (example: 2N2222A TIN/LEAD).
2. If requesting Lead (Pb) Free plated devices, add the suffix "PBFREE" to the part number when ordering (example: 2N2222A PBFREE).

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